

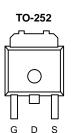
# N-Channel 150 V (D-S) MOSFET

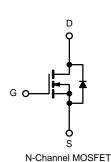
| PRODUCT SUMMARY     |                                 |                                 |                       |  |  |
|---------------------|---------------------------------|---------------------------------|-----------------------|--|--|
| V <sub>DS</sub> (V) | $R_{DS(on)}(\Omega)$            | I <sub>D</sub> (A) <sup>a</sup> | Q <sub>g</sub> (Typ.) |  |  |
| 150                 | 0.032 at V <sub>GS</sub> = 10 V | 40                              | 23 nC                 |  |  |
| 150                 | 0.045 at V <sub>GS</sub> = 8 V  | 35                              | 23110                 |  |  |

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- Extremely Low Q<sub>gd</sub> for Switching Losses
- 100 % R<sub>g</sub> Tested
- 100 % Avalanche Tested
- Compliant to RoHS Directive 2002/95/EC







#### **APPLICATIONS**

Primary Side Switch

| Parameter  | Symbol                 | Limit                             | Unit                 |     |  |
|--|------------------------|-----------------------------------|----------------------|-----|--|
| Drain-Source Voltage                               |                        | V <sub>DS</sub>                   | 150                  | V   |  |
| Gate-Source Voltage                                |                        | V <sub>GS</sub>                   | ± 20                 | V   |  |
|  | T <sub>C</sub> = 25 °C |                                   | 40                   |     |  |
| Continuous Danis Comment (T. 450 °C)               | T <sub>C</sub> = 70 °C | 1 .                               | 35                   |     |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) | T <sub>A</sub> = 25 °C | l <sub>D</sub>                    | 35.5 <sup>b, c</sup> |     |  |
|  | T <sub>A</sub> = 70 °C |                                   | 34.5 <sup>b, c</sup> | Α Α |  |
| Pulsed Drain Current                               |                        | I <sub>DM</sub>                   | 50                   |     |  |
| Continuous Source-Drain Diode Current              | T <sub>C</sub> = 25 °C |                                   | 4.5                  |     |  |
| Continuous Source-Drain Diode Current              | T <sub>A</sub> = 25 °C | I <sub>S</sub>                    | 2.6 <sup>b, c</sup>  |     |  |
| Single Pulse Avalanche Current                     | L = 0.1 mH             | I <sub>AS</sub>                   | 20                   |     |  |
| Single Pulse Avalanche Energy                      | L = 0.111111           | E <sub>AS</sub>                   | 20                   | mJ  |  |
|  | T <sub>C</sub> = 25 °C |                                   | 5.9                  |     |  |
| Maximum Power Dissipation                          | T <sub>C</sub> = 70 °C |                                   | 3.8                  | w   |  |
| Maximum Fower Dissipation                          | T <sub>A</sub> = 25 °C | P <sub>D</sub>                    | 3.1 <sup>b, c</sup>  | VV  |  |
|  | T <sub>A</sub> = 70 °C | 1 –                               | 2 <sup>b, c</sup>    |     |  |
| Operating Junction and Storage Temperature Range   |                        | T <sub>J</sub> , T <sub>stq</sub> | - 55 to 150          | °C  |  |

| THERMAL RESISTANCE RATINGS                  |              |                   |         |         |      |  |  |
|---|--------------|-------------------|---------|---------|------|--|--|
| Parameter                                   |              | Symbol            | Typical | Maximum | Unit |  |  |
| Maximum Junction-to-Ambient <sup>b, †</sup> | t ≤ 10 s     | R <sub>thJA</sub> | 33      | 40      | °C/W |  |  |
| Maximum Junction-to-Foot (Drain)            | Steady State | $R_{th,IF}$       | 17      | 21      | C/VV |  |  |

#### Notes

- a. Based on  $T_C$  = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 80 °C/W.



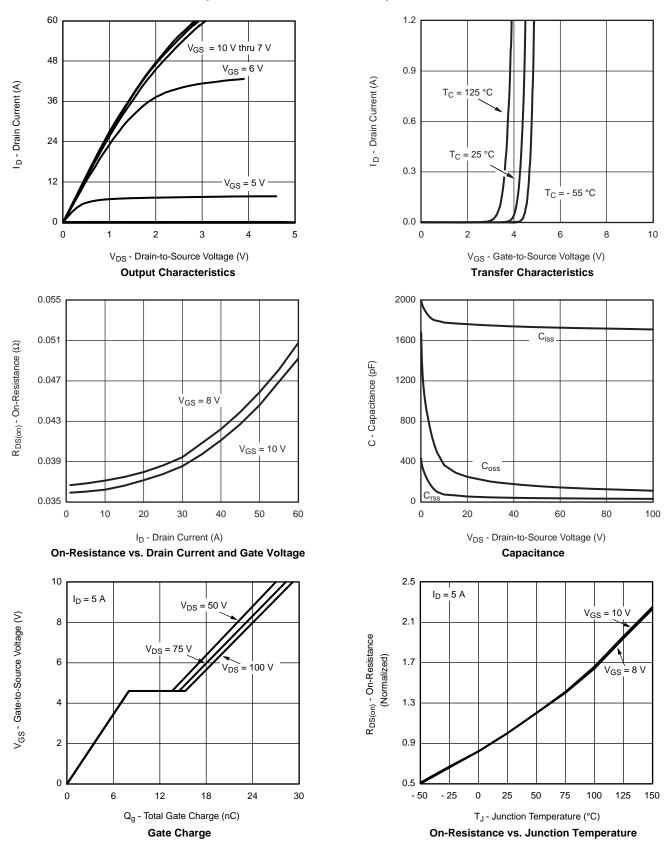
| Parameter                                     | Symbol                  | Test Conditions   | Min. | Тур.  | Max.  | Unit    |
|---|-------------------------|---|------|-------|-------|---------|
| Static  |                         |   |      |       | •     |         |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>         | $V_{GS} = 0 \text{ V, } I_D = 250  \mu\text{A}$                                     | 150  |       |       | V       |
| V <sub>DS</sub> Temperature Coefficient       | $\Delta V_{DS}/T_{J}$   | Λ\/ /T.   |      | 172   |       | ~~\//°C |
| V <sub>GS(th)</sub> Temperature Coefficient   | $\Delta V_{GS(th)}/T_J$ | $I_D = 250 \mu A$   |      | - 10  |       | mV/°C   |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>     | $V_{DS} = V_{GS}$ , $I_{D} = 250 \mu\text{A}$                                       | 1.5  |       | 2.5   | V       |
| Gate-Source Leakage                           | I <sub>GSS</sub>        | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                                   |      |       | ± 100 | nA      |
| Zana Oata Valtana Busin Oamant                | I <sub>DSS</sub>        | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V                                      |      |       | 1     |         |
| Zero Gate Voltage Drain Current               |                         | V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C              |      |       | 10    | μΑ      |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>      | $V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$                                    | 30   |       |       | Α       |
| Danie German Or Otata Basista and             | _ ` '                   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A  | 0.03 |       |       |         |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>     | $V_{GS} = 8 \text{ V, } I_{D} = 5 \text{ A}$  |      | 0.045 |       | Ω       |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>         | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 5 A  |      | 23    |       | S       |
| Dynamic <sup>b</sup>                          |                         |   | •    | •     | •     |         |
| Input Capacitance                             | C <sub>iss</sub>        |   |      | 1735  |       |         |
| Output Capacitance                            | C <sub>oss</sub>        | $V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$                    |      | 160   |       | pF      |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>        |   |      | 37    |       |         |
| Total Gate Charge                             | Qg                      | V <sub>DS</sub> = 75 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A                |      | 28.5  | 43    | nC      |
|   |                         |   |      | 23    | 35    |         |
| Gate-Source Charge                            | $Q_{gs}$                | $V_{DS} = 75 \text{ V}, V_{GS} = 8 \text{ V}, I_{D} = 5 \text{ A}$                  |      | 8     |       |         |
| Gate-Drain Charge                             | Q <sub>gd</sub>         |   |      | 6.5   |       |         |
| Gate Resistance                               | R <sub>g</sub>          | f = 1 MHz   |      | 0.85  | 1.3   | Ω       |
| Turn-on Delay Time                            | t <sub>d(on)</sub>      |   |      | 14    | 21    |         |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD}$ = 50 V, $R_L$ = 10 $\Omega$  |      | 12    | 18    |         |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$                     |      | 22    | 33    |         |
| Fall Time                                     | t <sub>f</sub>          |   |      | 6     | 10    | 200     |
| Turn-On Delay Time                            | t <sub>d(on)</sub>      |   |      | 16    | 24    | ns      |
| Rise Time                                     | t <sub>r</sub>          | $V_{DD}$ = 50 V, $R_L$ = 10 $\Omega$  |      | 12    | 18    |         |
| Turn-Off Delay Time                           | t <sub>d(off)</sub>     | $I_D \cong 5 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$                      |      | 20    | 30    |         |
| Fall Time                                     | t <sub>f</sub>          |   |      | 7     | 12    |         |
| <b>Drain-Source Body Diode Characteristi</b>  | cs                      |   |      |       |       |         |
| Continuous Source-Drain Diode Current         | I <sub>S</sub>          | T <sub>C</sub> = 25 °C  |      |       | 7.7   | Α       |
| Pulse Diode Forward Current <sup>a</sup>      | I <sub>SM</sub>         |   |      |       | 50    | ] ^     |
| Body Diode Voltage                            | V <sub>SD</sub>         | I <sub>S</sub> = 2.6 A  |      | 0.77  | 1.2   | V       |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>         |   |      | 63    | 95    | ns      |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>         | L = 5 A dl/dt = 100 A/up T = 25 °C  |      | 110   | 165   | nC      |
| Reverse Recovery Fall Time                    | t <sub>a</sub>          | $I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$ |      | 49    |       | 20      |
| everse Recovery Rise Time t <sub>b</sub>      |                         |   |      | 14    |       | ns      |

#### Notes:

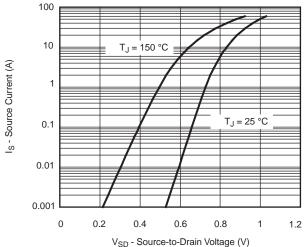
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$
- a. Guaranteed by design, not subject to production testing.

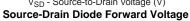
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

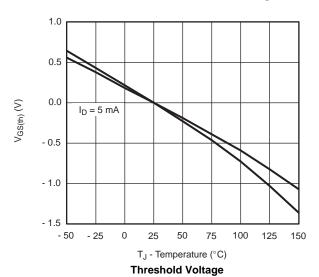






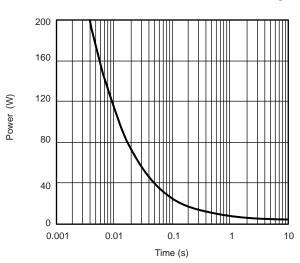




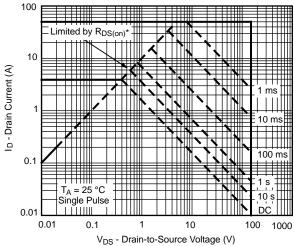


0.20  $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$  - Drain-to-Source On-Resistance  $(\Omega)$  $I_D = 5 \text{ A}$ 0.16 0.12  $T_J = 125$  °C 0.08  $T_J = 25$  °C 0.04 0.00 0 2 4 6 10 V<sub>GS</sub> - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage



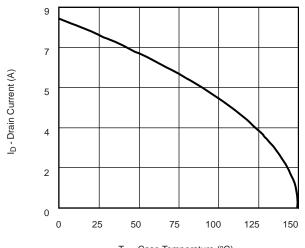
Single Pulse Power, Junction-to-Ambient



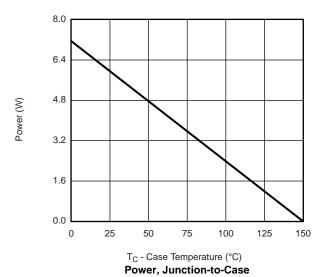
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

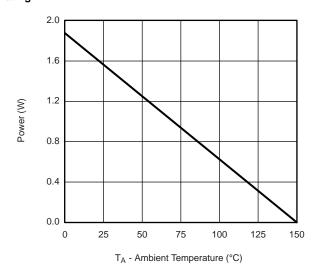
Safe Operating Area, Junction-to-Ambient





T<sub>C</sub> - Case Temperature (°C) **Current Derating\*** 

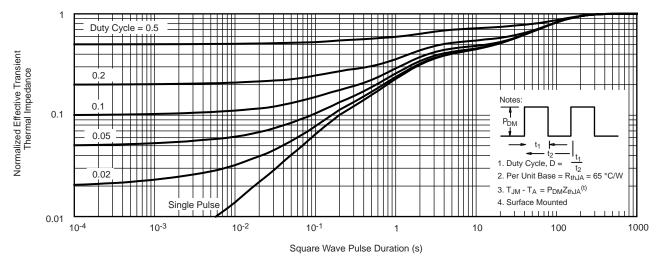




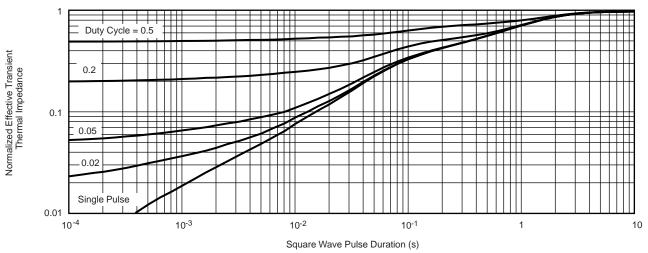
Power, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





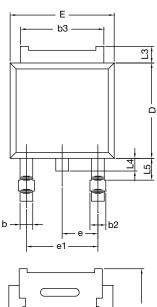
Normalized Thermal Transient Impedance, Junction-to-Ambient

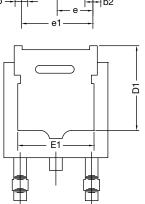


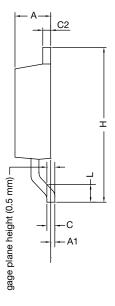
Normalized Thermal Transient Impedance, Junction-to-Foot



# **TO-252AA CASE OUTLINE**







|                                 | MILLIMETERS |       | INC       | HES   |  |
|---------------------------------|-------------|-------|-----------|-------|--|
| DIM.                            | MIN.        | MAX.  | MIN.      | MAX.  |  |
| А                               | 2.18        | 2.38  | 0.086     | 0.094 |  |
| A1                              | -           | 0.127 | -         | 0.005 |  |
| b                               | 0.64        | 0.88  | 0.025     | 0.035 |  |
| b2                              | 0.76        | 1.14  | 0.030     | 0.045 |  |
| b3                              | 4.95        | 5.46  | 0.195     | 0.215 |  |
| С                               | 0.46        | 0.61  | 0.018     | 0.024 |  |
| C2                              | 0.46        | 0.89  | 0.018     | 0.035 |  |
| D                               | 5.97        | 6.22  | 0.235     | 0.245 |  |
| D1                              | 5.21        | -     | 0.205     | -     |  |
| Е                               | 6.35        | 6.73  | 0.250     | 0.265 |  |
| E1                              | 4.32        | -     | 0.170     | -     |  |
| Н                               | 9.40        | 10.41 | 0.370     | 0.410 |  |
| е                               | 2.28 BSC    |       | 0.090 BSC |       |  |
| e1                              | 4.56 BSC    |       | 0.180 BSC |       |  |
| L                               | 1.40        | 1.78  | 0.055     | 0.070 |  |
| L3                              | 0.89        | 1.27  | 0.035     | 0.050 |  |
| L4                              | -           | 1.02  | -         | 0.040 |  |
| L5                              | 1.14        | 1.52  | 0.045     | 0.060 |  |
| ECN: X12-0247-Rev. M, 24-Dec-12 |             |       |           |       |  |

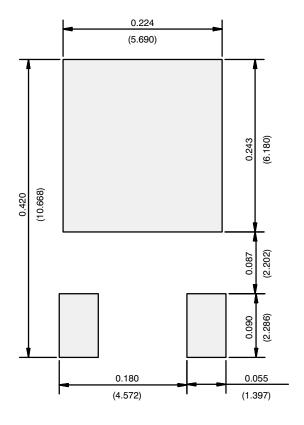
ECN: X12-0247-Rev. M, 24-Dec-1: DWG: 5347

#### Note

• Dimension L3 is for reference only.



## **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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